Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/717,334	HAN ET AL.	
Examiner	Art Unit	
Lvnne Edmondson	1725	

SEARCHED			
Class	Subclass	Date	Examiner
228	2.1	3/1/2005	LRE
228	112.1	3/1/2005	LRE
updated	previous	8/16/2005	LRE
updated	previous	2/22/2006	LRE
	-		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventor Name Search - PALM	3/1/2005	LRE	
EAST text search	3/1/2005	LRE	
updated Inventor Name Search - IFW	8/16/2005	LRE	
EAST text search	8/16/2005	LRE	
updated Inventor Name Search - IFW	2/22/2006	LRE	
EAST text search	2/22/2006	LRE	